## **REMARKS**

Applicants respectfully request entry of the foregoing and reexamination and reconsideration of the application, as amended, in light of the remarks that follow.

Conventional insulating films produced by converting a siloxane resin into silica  $(SiO_2)$  have a dielectric constant of from 3.5 to 4.2, which is too high for high frequency applications in semiconductor devices. In contrast, the present invention provides a process for producing a film having Si-C-Si structure by irradiating a siloxane compound with an electron dose of from 1 to 200  $\mu$ C/cm<sup>2</sup>. The resulting film exhibits, in combination, a low dielectric constant of 3 and or lower and improved mechanical properties, e.g., cracking resistance.

Claims 1-15 are rejected under 35 U.S.C. §102(e) over U.S. Patent No. 6,204,201 ("Ross-201"). In addition, Claim 17 is rejected under 35 U.S.C. §102(e) or, in the alternative, under 35 U.S.C. §103(a) over Ross-201. Ross-201 was filed on June 11, 1999. In contrast, the attached Declaration Under 37 § C.F.R. 1.131 establishes that Applicants reduced to practice the present invention prior to June 11, 1999. Thus, Ross-201 is not prior art to the above-identified application. Therefore, the rejections over Ross-201 should be withdrawn.

The Information Disclosure Statement filed with this Amendment discloses U.S.

Patent No. 6,207,555 ("Ross-555"). Ross-555 discloses forming vias, interconnects and wiring lines between devices by applying a dielectric layer, such as a siloxane polymer, to a substrate; and irradiating the dielectric layer under conditions "sufficient to cure" an upper portion of the dielectric layer while "not substantially curing" a lower portion of the dielectric

semiconductor device, between the cured upper layer and the substrate, Ross-555 teaches away from the independent Claim 1 limitations of "...applying directly on a semiconductor device a film comprising at least one siloxane compound; and irradiating the film comprising at least one siloxane compound with electron beams at an irradiation dose of from 1 to 200 μC/cm<sup>2</sup> to thereby react the siloxane compound *throughout* the film and generate silicon carbide bonds represented by Si-C-Si while maintaining the dielectric constant of the film at a value of 3 or lower, ...". Similarly, because Ross-555 requires an uncured lower layer between the cured upper layer and the substrate, Ross-555 teaches away from the independent Claim 20 limitations of "...providing a substrate comprising a material selected from the group consisting of *elemental Si*, SiO, and SiN; applying *directly* on the substrate a film comprising at least one siloxane compound; and irradiating the film comprising at least one siloxane compound with electron beams at an irradiation dose of from 1 to 200 μC/cm<sup>2</sup> to thereby react the siloxane compound throughout the film and convert the siloxane to form silicon carbide bonds represented by Si-C-Si while maintaining the dielectric constant of the film at a value of 3 or lower, ...". The specification at page 36, Table 4, reproduced below, demonstrates that electron beam irradiation improves the cracking resistance of siloxane films.

Table 4

Example	Before electron beam irradiation				After electron beam irradiation			
	k	Hard-	Si-C-Si	Crack-	k	Hard-	Si-C-Sı	Crack-
Ł	1	ness	bond	ing		ness	bond	ing
	:	(GPa)		resist-		(GPa)	i.	resist-
		<u> </u>		ance				ance
Example	1		1	Ī	į			
8	2.6	0.71	Absent	· · ·	2.6	0.9	Present	
Example	İ	İ	1	į.		1		l .
9	2.3	0.50	Absent		2.3	0.9_	Present	<u> </u>
Example			i			· ·	1	Ĭ i
10	2.2	0.25	Absent	я	2.2	0.6	Present	0
Example			!					
11	2.2	0.25	Absent	(_;	2.2	0.8	Present	0
Example			İ	1			!	
12	2.6	0.71	Absent	į r	2.7	1.1	Present	<u> </u>
Example								
13	2.3	0.50	Absent		2.3	0.8	Present	0
Example							1	
14	2.6	0.71	Absent		2.6	1.0	Present	

Table 4 shows that the irradiated siloxane films of independent Claims 1 and 20 have improved cracking resistance relative to <u>Ross-555</u>'s irradiated siloxane dielectric layer having a crack-prone, substantially uncured lower portion.

The Information Disclosure Statement also discloses an assertion by Applied Materials that Matthew Ross is a co-inventor of the above-identified application. We have investigated confidential documents provided to Applicants by Applied Materials in support of Applied Materials' assertion. However, our review and analysis of the confidential documents indicates that Matthew Ross functioned only as a technician showing Atsushi Shiota how to adjust electron dose on an electron beam exposure machine. We have seen no evidence establishing that Matthew Ross is a co-inventor of the above-identified application.

In view of the foregoing amendments and remarks, Applicants respectfully submit that the application is in condition for allowance. Applicants respectfully request favorable consideration and prompt allowance of the application.

Should the Examiner believe that anything further is necessary in order to place the application in even better condition for allowance, the Examiner is invited to contact Applicants' undersigned attorney at the telephone number listed below.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

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# Attachments:

McGraw-Hill Dictionary of Scientific and Technical Terms, 5<sup>th</sup> edition, page 553 Declaration Under 37 § C.F.R. 1.131 Information Disclosure Statement

Customer Number

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NFO CPU

deviation to the maximum modulating frequency of a frequency modulated system under specifical conditions. (\*) devé ashor, far ho

**deviation sensitivity** [8,33]. A value expressed as the ratio of the rate of change in course indication to the demands from the course line. (\*) devic assion, set is a two-de-

deviation survey [19,180,180]. Measurements made during a drilling operation to determine the angle from which the bit has deviated from the vertical angle cover ashon sony of

deviation table [5.63]. A table of the deviation of a magnetic you pass only mous headings, magnetic or compass, for an air relativoimpass, this adomnation is usually placed or a cardy alled a deviation (aid.) Also known as magnetic compass table { deve ashon table }

**deviatonic stress** [MER]. The portion of the total stress that differs from an isostatic hydrostatic pressure; it is equal to the difference between the total stress and the spherical stress { [Jevyebo]tanik stress }

deviatoric stress [Gror]. A condition in which the stress components operating at a point in a body are not the same in every direction. Also known as differential stress. [ ] (deve-b[torik] stress.]

**device** [COMPLESCI] A general-purpose term used often in discriminately, to refer to a computer component or the computer itself. [FITCIB] An electronic element that cannot be divided without destroying its stated function, commonly applied to active elements such as transistors and transducers. [Fig.] A mechanism, tool or other piece of equipment designed to specific uses. All VIS.]

**device address** [commark or The binary code which contemponds to a unique device, referred to when relecting this specific device — di'vis 5 dres.;

device assignment [COMPULSE] The use of a logical device number used in conjunction with an input/output instruction, and made to refer to a specific device. [ dr/vis of simmont ]

device cluster [compt.1.8c1]. A collection of peripheral devices (usually terminals) that have a common control unit. { di'vīs [klaster.].

device control character [COMPUTSCI]. A special character used to direct a peripheral or communications device to perform a specific function. [dr'vis kon'trôl karaktor]

device driver [compt], sc1: A subroutine which handles a complete input/output operation. - di'vis ,drīvər }

**device-end condition** [COMPUT SCI] The completion of an input/output operation, such as the transfer of a complete data block, recognized by the hardware in the absence of a byte count. { di'vis ",end kon'dishron"

device end pending [coupt 1861]. A hardware error in which a peripheral device does not respond when addressed by the central processing unit, usually because the device has become inoperative divisional pendition.

**device flag** [FOMPLES CO.] A flip flop output which indicates the ready status of an input output device. I divis flag [

**device independence** [COMPCL (CF) Property of a computer program whose successful execution extitute recompitations does not depend on the type of physical unit associated with a given logical contemployed by the program. The civil side periods

device-name assignment in property. The distribution of periphers also be a consistent with the property and the distribution of the distribution of the distribution.

device number (1994) with the first of the second of the s

**device selector** a control is of the category which categorial transfer of command pulses to a specific input output for conditions a Taketor.

devil See devil float devision

devil float (1886). A hand float communicated in resolution of that connect and resolution the status of that (12, 19, 39) is keen for the professional. As extenses the probability of the status of

and 2 are constant. Also known as devil on two sticks 📑 devi

**devil's pitchfork** [DESTNO]. A tool with flexible prongs used in recovery of a bit, underreamer, cutters, or such lost during drilling. It devials pich fork t

**devitrification** [CHEM]. The process by which the glassy texture of a material is converted into a crystalline texture [ ] dely it us to kashon?

devitrified glass [MATER]. A glassy material which has been changed from a vitreous to a brittle crystalline state during manufacture. [] dévetro fid [glas.]

devolatilize [CH ST 186] To remove volatile components from a material [1,de'val-oro,lic]:

**Devonian** [Grof] The fourth period of the Paleozoic Era, covering the geological time span between about 412 and 354 10' years before present [] di vone on []

**De Vries effect** [Grochest] A relatively short-term oscillation, on the order of 100 years, in the radiocarbon content of the atmosphere, and the resulting variation in the apparent radiocarbon age of samples. { d5/vr6///fckt }

**devrinol** [ORG CHEM] C.-H.2(O.N. A brown solid with a melting point of 68.5–70.5 C; slight solubility in water; used as a herbicide for crops. Also known as 2-(\alpha-naphthoxy)-N.N. diethylpropionamide. { 'devro,nol.}

**dew** [1171] Water condensed onto grass and other objects near the ground, the temperature, of which have fallen below the dew point of the surface air because of radiational cooling during the night but are still above treezing. { du }

Dewar calorimeter (1836). 1. Any calorimeter in which the sample is placed inside a Dewar flask to minimize heat losses. 2. A calorimeter for determining the mean specific heat capacity of a solid between the boiling point of a cryogenic liquid, such as liquid oxygen, and room temperature, by measuring the amount of the liquid that evaporates when the specimen is dropped into the liquid. [[duor\_labo\*rimodor]]

**Dewar flask** [FEOS] A vessel having double walls, the space between being evacuated to prevent the transfer of heat and the surfaces facing the vacuum being heat-reflective; used to hold liquid gases and to study low-temperature phenomena. [ 'düər flask']

**Dewar structure** [ORG C10 M]. A structural formula for benzene that contains a bond between opposite atoms. [ 'du'or | strokehor ]

**dewatere** [MECHENG] Wet type mechanical classifier (solids separator) in which solids settle out of the carrier liquid and are concentrated to recovery. { dewod-arrar}

dewatering [18:6] 1. Removal of water from solid material by wet classification, centriliagation, filtration, or similar solid-haurd separation techniques. 2. Removing or draining water from an enclosure or a structure, such as a riverbed, caisson, or mine shaft, by pumping or evaporation. { delwod acin }

dewaxed oil [MATIR] Lubricating oil that has had a portion of the way removed [ | de'wakst 'oil |

dewaxing [CH M FNG] Ecmoving wax from a material or object a process tred to separate solid hydrocarbons from petroleum. [-|de/wal-sin/]

**dewcap** [OPTICS] An open tabe attached to the end of a refraction telescope to prevert mosture from condensing on the objective disk (p.

dew cell of a constraint on used to accertain. The device minimizers string of a fair of strucker, has coccers, always wound structure and to be estable and a veried with a wicking wetted a five water sould be consisted at recess of than a fortile at effective, potential and appear to the wire causes of flow of a fair to the sould be appeared to the wire causes of the temperature of the souldon minimize who have cause the temperature of the souldon minimizes are pressure is in equilibrium with that of the ambient and the durisely.

**Dewclaw** [MERT 2001] 1. A vestigial digit on the foot of a mammal which does not reach the ground. 2. A claw or hoot terminating sugmenting in diskloss.

dewetting [MI]. I have of solder away from the soldered surtion during tenerating following in that soldering — de weden deweylite. [MI] FRAT — A maxime of chirochry solite and stev

#### DEVONIAN

	UATER*AR*
CENOZOIC	LENT ALL
	et "Viton.
MESOZOIC	Jule 4.52 %
	THE ASSET
	HEM.EN
	FENNSYCHAN AN
AH	MISSASSIM COURTHAIN
PALEDZOIC	F/EVPHHAN
	SILORIAN
	UPOOV*CIAN
	CHINDRIAN
	PRECAMBRIAN

Chart showing relationship of Devonian to other periods.

### DEWAR FLASK



Appreal Dewär containers

On the cover: Photomicrograph of crystals of vitamin B<sub>1</sub>. (Dennis Kunkel, University of Hawaii)

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In addition, material has been drawn from the following references: R. E. Huschke, Glossary of Meteorology, American Meteorological Society, 1959; U.S. Air Force Glossary of Standardized Terms, AF Manual 11-1, vol. 1, 1972; Communications-Electronics Terminology, AF Manual 11-1, vol. 3, 1970; W. H. Allen, ed., Dictionary of Technical Terms for Aerospace Use. 1st ed., National Aeronautics and Space Administration, 1965; J. M. Gilliand, Solar-Terrestrial Physics: A Glossary of Terms and Abbreviations, Royal Aircraft Establishment Technical Report 67158, 1967; Glossary of Air Traffic Control Terms, Federal Aviation Agency: A Glossary of Range Terminology, White Sands Missile Range, New Mexico, National Bureau of Standards, AD 467-424; A DOD Glossary of Mapping, Charting and Geodetic Terms. 1st ed., Department of Defense, 1967; P. W. Thrush, compand ed., A Dictionary of Mining, Mineral, and Related Terms, Bureau of Mines, 1968; Nuclear Terms: A Glossary, 2d ed., Atomic Energy Commission; F. Casey, ed., Compilation of Terms in Information Sciences Technology, Federal Council for Science and Technology, 1970; Glossary of Stinfo Terminology, Office of Aerospace Research, U.S. Air Force, 1963; Naval Dictionary of Electronic, Technical, and Imperative Terms. Bureau of Naval Personnel, 1962; ADP Glossary, Department of the Navy, NAVSO P-3097.

# McGRAW-HILL DICTIONARY OF SCIENTIFIC AND TECHNICAL TERMS, Fifth Edition

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